

Search Notes**Application/Control No.**

10/773,946

Examiner

JEAN B. FLEURANTIN

Applicant(s)/Patent under Reexamination

LEUNG, YIU-MING

Art Unit

2162

SEARCHED

Class	Subclass	Date	Examiner
707	1-10	12/21/2006	JB
707	100-104.1	12/21/2006	JB
707	200-206	12/21/2006	JB
709	217-218	12/21/2006	JB
715	214-215	12/21/2006	JB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	12/21/2006	JB
707/CCLS & 709/CCLS & 715/CCLS Inventors Sarch & all related applications have been reviewed for possible Double Patenting.	12/21/2006	JB
NPL - ACM	12/21/2006	JB
NPL - IEEE	12/21/2006	JB
Consulted - TQAS Panel 101	7/6/2006	JB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner